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May 2016

# FGY160T65SPD\_F085 650V, 160A Field Stop Trench IGBT With Soft Fast Recovery Diode

#### **Features**

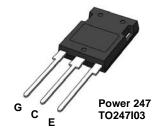
- · Automotive Qualified
- Very low saturation voltage :  $V_{CE(sat)} = 1.6 \text{ V(Typ.)} @ I_C = 160 \text{ A}$
- Maximum junction temperature : T<sub>J</sub> = 175 °C
- · Positive temperature Co-efficient
- · Tight parameter distribution
- · High input impedance
- 100% of the parts are dynamically tested
- Short circuit ruggedness > 6 μs @ 25 °C
- Copacked with soft, fast recovery Extremefast diode

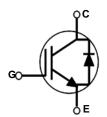
### **Benefits**

- Very Low conduction and switching losses for a high efficiency operation in various applications
- Rugged transient reliability
- Outstanding parallel operation performance with balance current sharing
- Low EMI

### **Applications**

- · Traction inverter for HEV/EV
- Auxiliary DC/AC converter
- Motor drives
- Other power-train applications requiring high power switch





### **Absolute Maximum Ratings**

| Symbol               | Description   |                           | Ratings     | Units |
|----------------------|---|---------------------------|-------------|-------|
| V <sub>CES</sub>     | Collector to Emitter Voltage  |                           | 650         | V     |
| V <sub>GES</sub>     | Gate to Emitter Voltage   |                           | ± 20        | V     |
| I <sub>C</sub>       | Collector Current (Note1)   | @ T <sub>C</sub> = 25 °C  | 240         | А     |
| 10                   | Collector Current   | @ T <sub>C</sub> = 100 °C | 220         | А     |
| I <sub>Nominal</sub> | Nominal Current   |                           | 160         | А     |
| I <sub>CM</sub>      | Pulsed Collector Current  |                           | 480         | A     |
| I <sub>F</sub>       | Diode Forward Current (Note1)   | @ T <sub>C</sub> = 25 °C  | 240         | А     |
|                      | Diode Forward Current   | @ T <sub>C</sub> = 100 °C | 188         | А     |
| P <sub>D</sub>       | Maximum Power Dissipation   | @ T <sub>C</sub> = 25 °C  | 882         | W     |
|                      | Maximum Power Dissipation   | @ T <sub>C</sub> = 100 °C | 441         | W     |
| SCWT                 | Short Circuit Withstand Time  | @ T <sub>C</sub> = 25 °C  | 6           | μS    |
| dV/dt                | Voltage Transient Ruggedness (Note2)                                    |                           | 10          | V/ns  |
| T <sub>J</sub>       | Operating Junction Temperature  |                           | -55 to +175 | °C    |
| T <sub>stg</sub>     | Storage Temperature Range   |                           | -55 to +175 | °C    |
| T <sub>L</sub>       | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds |                           | 300         | °C    |

#### Notes:

1: Limited by bondwire

2:  $V_{CC}$  = 400 V,  $V_{GE}$  = 15 V,  $I_{CE}$  = 480 A, Inductive Load

## **Thermal Characteristics**

| Symbol                 | Parameter                               | Тур. | Max. | Units |
|------------------------|---|------|------|-------|
| $R_{\theta JC}(IGBT)$  | Thermal Resistance, Junction to Case    | -    | 0.17 | °C/W  |
| $R_{\theta JC}(Diode)$ | Thermal Resistance, Junction to Case    | -    | 0.32 | °C/W  |
| $R_{\theta JA}$        | Thermal Resistance, Junction to Ambient | -    | 40   | °C/W  |

## **Package Marking and Ordering Information**

| Device Marking Device |              | Package           | Packing Type | Qty per Tube |      |
|-----------------------|--------------|-------------------|--------------|--------------|------|
|                       | FGY160T65SPD | FGY160T65SPD_F085 | TP-247       | Tube         | 30ea |

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### Electrical Characteristics of the IGBT $T_J = 25$ °C unless otherwise noted

| Symbol                       | Parameter                                    | Test Conditions  | Min. | Тур. | Max.  | Units |
|------------------------------|--|--|------|------|-------|-------|
| Off Charac                   | teristics                                    |  |      |      |       |       |
| BV <sub>CES</sub>            | Collector to Emitter Breakdown Voltage       | $V_{GE} = 0V$ , $I_C = 1mA$  | 650  | -    | -     | V     |
| $\Delta BV_CES \ \Delta T_J$ | Temperature Coefficient of Breakdown Voltage | V <sub>GE</sub> = 0V, I <sub>C</sub> = 1mA   | -    | 0.6  | -     | V/°C  |
| I <sub>CES</sub>             | Collector Cut-Off Current                    | $V_{CE} = V_{CES}, V_{GE} = 0V$  | -    | -    | 40    | μΑ    |
| I <sub>GES</sub>             | G-E Leakage Current                          | $V_{GE} = V_{GES}, V_{CE} = 0V$  | -    | -    | ± 250 | nA    |
| On Charac                    | teristics                                    |  |      |      |       |       |
| V <sub>GE(th)</sub>          | G-E Threshold Voltage                        | $I_C = 160$ mA, $V_{CE} = V_{GE}$  | 4.3  | 5.3  | 6.3   | V     |
|                              |  | I <sub>C</sub> = 160A, V <sub>GE</sub> = 15V   | -    | 1.6  | 2.05  | V     |
| V <sub>CE(sat)</sub>         | Collector to Emitter Saturation Voltage      | I <sub>C</sub> = 160A, V <sub>GE</sub> = 15V,<br>T <sub>J</sub> = 175 °C   | -    | 2.15 | -     | V     |
| Dynamic C                    | Characteristics                              |  |      |      |       |       |
| C <sub>ies</sub>             | Input Capacitance                            |  | -    | 6710 | -     | pF    |
| C <sub>oes</sub>             | Output Capacitance                           | $V_{CE} = 30V, V_{GE} = 0V,$   | -    | 450  | -     | pF    |
| C <sub>res</sub>             | Reverse Transfer Capacitance                 | f = 1MHz   | -    | 55   | -     | pF    |
| R <sub>G</sub>               | Internal Gate Resistance                     | f = 1MHz   | -    | 3    | -     | Ω     |
| Switching                    | Characteristics                              |  | •    | •    |       |       |
| T <sub>d(on)</sub>           | Turn-On Delay Time                           |  | -    | 53   | -     | ns    |
| T <sub>r</sub>               | Rise Time                                    |  | -    | 197  | -     | ns    |
| T <sub>d(off)</sub>          | Turn-Off Delay Time                          | $V_{CC} = 400V, I_{C} = 160A,$   | -    | 98   | -     | ns    |
| T <sub>f</sub>               | Fall Time                                    | $R_G = 5\Omega$ , $V_{GE} = 15V$ ,   | -    | 141  | -     | ns    |
| E <sub>on</sub>              | Turn-On Switching Loss                       | Inductive Load, T <sub>J</sub> = 25 °C   | -    | 12.4 | -     | mJ    |
| E <sub>off</sub>             | Turn-Off Switching Loss                      |  | -    | 5.7  | -     | mJ    |
| E <sub>ts</sub>              | Total Switching Loss                         |  | -    | 18.1 | -     | mJ    |
| T <sub>d(on)</sub>           | Turn-On Delay Time                           |  | -    | 52   | -     | ns    |
| T <sub>r</sub>               | Rise Time                                    |  | -    | 236  | -     | ns    |
| T <sub>d(off)</sub>          | Turn-Off Delay Time                          | $V_{CC}$ = 400V, $I_{C}$ = 160A,<br>$R_{G}$ = 5 $\Omega$ , $V_{GE}$ = 15V,<br>Inductive Load, $T_{J}$ = 175 $^{\circ}$ C | -    | 104  | -     | ns    |
| T <sub>f</sub>               | Fall Time                                    |  | -    | 204  | -     | ns    |
| E <sub>on</sub>              | Turn-On Switching Loss                       |  | -    | 21   | -     | mJ    |
| E <sub>off</sub>             | Turn-Off Switching Loss                      |  | -    | 8.5  | -     | mJ    |
| E <sub>ts</sub>              | Total Switching Loss                         |  | -    | 29.5 | -     | mJ    |

### **Electrical Characteristics of the IGBT** (Continued)

| Symbol          | Parameter                | Test Conditions                                  | Min. | Тур. | Max | Units |
|-----------------|--------------------------|--|------|------|-----|-------|
| $Q_g$           | Total Gate Charge        |  | -    | 163  | 245 | nC    |
| Q <sub>ge</sub> | Gate to Emitter Charge   | $V_{CE} = 400V, I_{C} = 160A,$<br>$V_{GE} = 15V$ | -    | 50   | -   | nC    |
| $Q_{gc}$        | Gate to Collector Charge | VGE - 10 V                                       | -    | 49   | ı   | nC    |

# Electrical Characteristics of the Diode $T_J = 25$ °C unless otherwise noted

| Symbol          | Parameter                                     | Test Conditions                                      |                                   | Min. | Тур. | Max | Units |
|-----------------|---|--|-----------------------------------|------|------|-----|-------|
| V <sub>FM</sub> | Diode Forward Voltage                         | I <sub>F</sub> = 160A                                | $T_J = 25$ °C                     | -    | 1.4  | 1.7 | V     |
| FINI            |   | .,   | $T_{J} = 175  {}^{\circ}\text{C}$ | -    | 1.35 | -   |       |
| Е               | E <sub>rec</sub> Reverse Recovery Energy      | $V_{CE} = 400V, I_F = 160A,$ $dI_F/dt = 1000A/\mu s$ | $T_J = 25$ °C                     | -    | 598  | -   | 1     |
| ⊏rec            |   |  | T <sub>J</sub> = 175 °C           | =    | 4000 | -   | - μJ  |
| T               | T <sub>rr</sub> Diode Reverse Recovery Time   |  | T <sub>J</sub> = 25 °C            | -    | 132  | -   | ns    |
|                 |   |  | T <sub>J</sub> = 175 °C           | -    | 245  | -   |       |
| Q <sub>rr</sub> | Q <sub>rr</sub> Diode Reverse Recovery Charge |  | $T_J = 25$ °C                     | =    | 3.3  | -   | иC    |
| ~11             | 2.535 .ts.5.55 .toobvory onlings              |  | T <sub>J</sub> = 175 °C           | -    | 12.5 | -   | ,,,   |

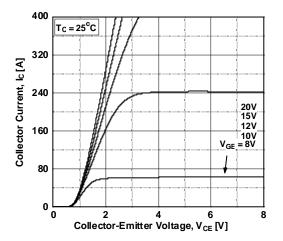


Figure 1. Typical Output Characteristics

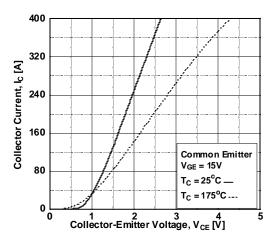


Figure 3. Typical SaturationVoltage

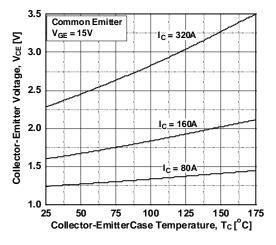
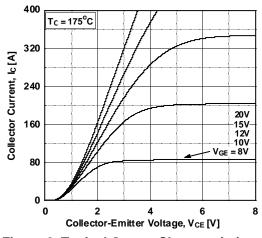


Figure 5. Saturation Voltage vs. Case

Temperature at Varient Current Level



**Figure 2. Typical Output Characteristics** 

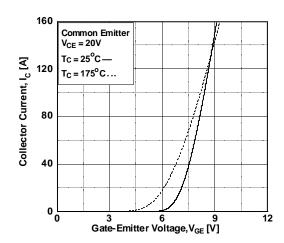


Figure 4. Transfer Charactersistics

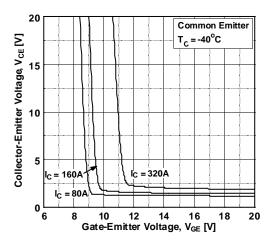


Figure 6. Saturation Voltage vs. VGE

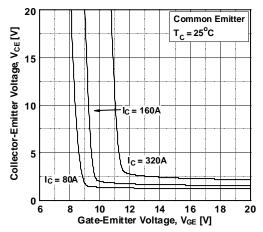


Figure 7. Saturation Voltage vs. VGE

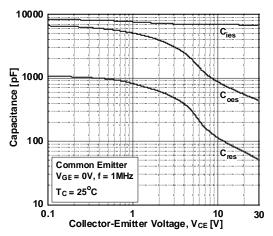


Figure 9. Capacitance Charateristics

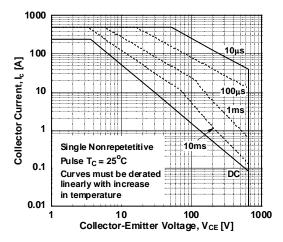


Figure 11. SOA Charateristics

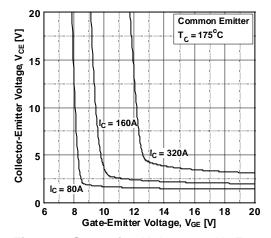


Figure 8. Saturation Voltage vs. VGE

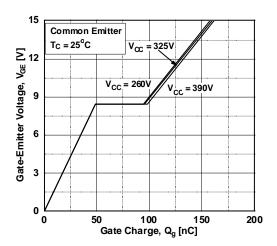


Figure 10. Gate Charge Charateristics

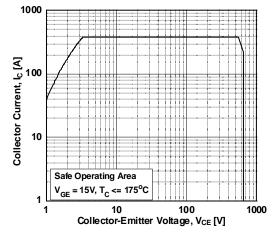


Figure 12. Turn off Switching SOA Charateristics

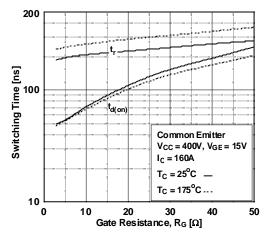


Figure 13. Turn-on Charaterizatics vs. Gate

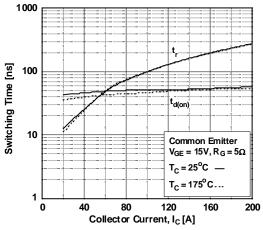


Figure 15. Turn-on Charaterizatics vs.

Collector Current

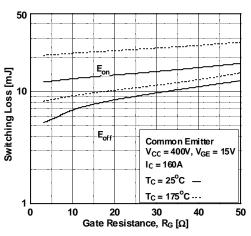


Figure 17. Switching Loss vs. Gate Resistance

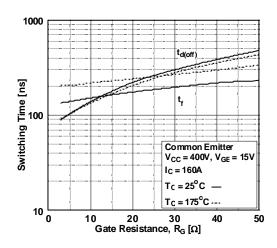


Figure 14. Turn-off Charaterizatics vs. Gate

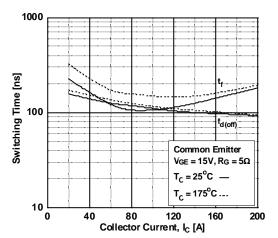


Figure 16. Turn-off Charaterizatics vs.

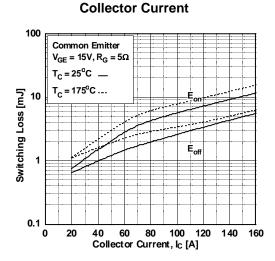


Figure 18. Switching Loss vs. Collector Current

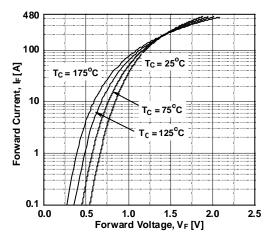


Figure 19. Forward Charateristics

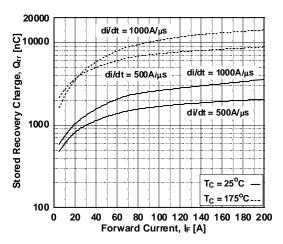


Figure 21. Stored Charge

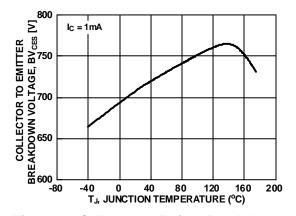


Figure 23. Collector to Emitter Breakdown

Voltage vs. Junction Temperature

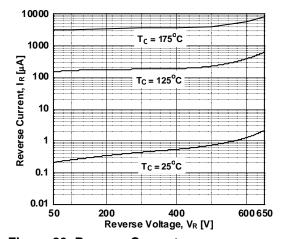


Figure 20. Reverse Current

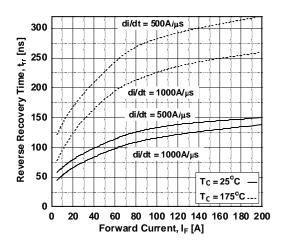


Figure 22. Reverse Recovery Time

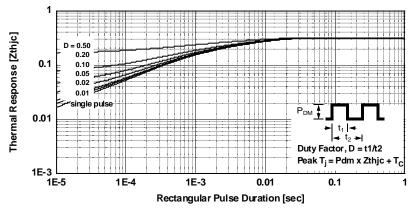


Figure 24. Transient Termal Impedance of Diode

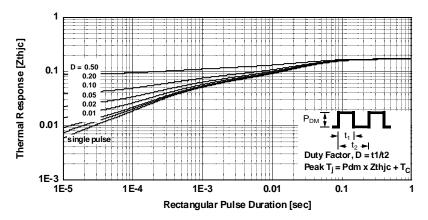
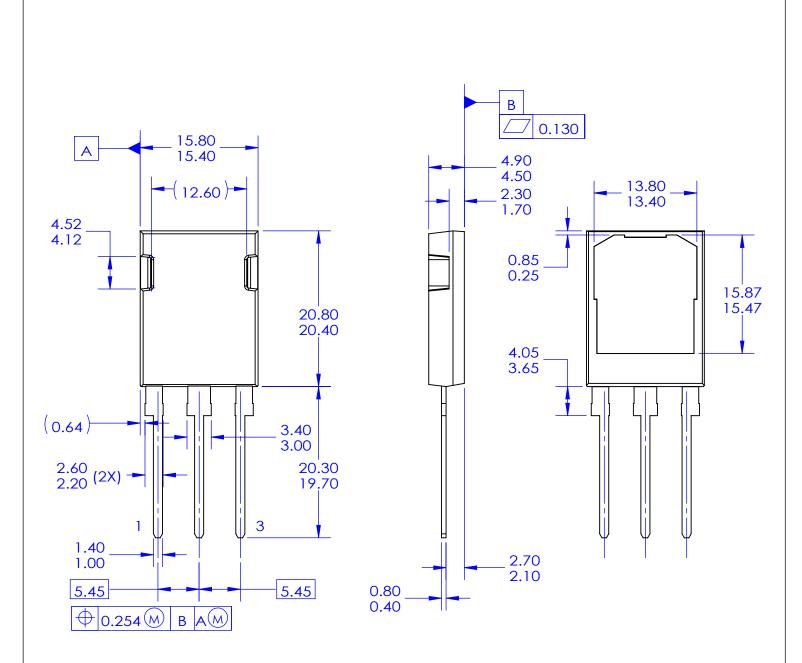


Figure 25. Transient Termal Impedance of IGBT

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